Search Notes

Application/Control No.	Applicant(s)/Patent und Reexamination	er
10/828,881	INNAN ET AL.	
Examiner	Art Unit	
TAN X. DINH	2653	

Subclass	Date	Examiner
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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Interference Search History Printout		2/3/2006	T.D	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST (see seaech history printout)	2/3/2006	T.D		
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